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SHEET 1 OF 1

INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)				ATTY. DOCKET NO. 071971-0548	SERIAL NO. Not Yet Assigned 10/5/8003	
				APPLICANT Hideo NAKAGAWA, et al.		
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EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code(s if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
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